## Notice of References Cited Application/Control No. 10/702,195 Examiner Khareem E. Almo Applicant(s)/Patent Under Reexamination BAIG ET AL. Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2003/0141919	07-2003	Wang et al.	327/390
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